| Substitute Form PTO-1449 (Modified) | U.S. Department of Commerce Patent and Trademark Office | Attorney Docket No. 20228-0013US1 | Application No. 10/580,698 |
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| **Information Disclosure Statement by Applicant** (Use several sheets if necessary) | | Applicant Damian Fiolka et al. | |
| (37 CFR §1.98(b)) | | Filing Date November 29, 2006 | Group Art Unit 2872 |

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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute Disclosure Form (PTO-1449)